

EE 566
Solid State Devices
Assignment 5
Solutions

PROBLEM 1

First we list some fundamental physical constants:

$$\begin{aligned}
 h &:= 6.62606876 \cdot 10^{-34} \cdot \text{joule} \cdot \text{sec} & q &:= 1.602176462 \cdot 10^{-19} \cdot \text{coul} & \text{eV} &:= 1.602176462 \cdot 10^{-19} \cdot \text{joule} \\
 m_0 &:= 9.10938188 \cdot 10^{-31} \cdot \text{kg} & k &:= 8.617 \cdot 10^{-5} \frac{\text{eV}}{\text{K}} & \hbar &:= \frac{h}{2\pi} & c &:= 3 \cdot 10^8 \frac{\text{m}}{\text{sec}} & \text{meV} &:= .001 \text{eV} \\
 & & & & & & \text{nm} &:= 10^{-9} \text{m}
 \end{aligned}$$

Then we can list the properties of GaAs since the well is made of this material. The AlGaAs outside serves to make it an almost infinite potential well:

$$m_e := .063 \cdot m_0 \quad m_{hh} := .51 \cdot m_0 \quad m_{lh} := .082 \cdot m_0 \quad E_g := 1.424 \text{eV} \quad L := 8 \cdot \text{nm}$$

Now we calculate the total effective mass for holes:

$$m_p := \left(m_{hh}^{\frac{3}{2}} + m_{lh}^{\frac{3}{2}} \right)^{\frac{2}{3}} \quad m_p = 0.532 m_0$$

Then we use the basic formula to calculate the first eigenvalue for electrons and holes inside the quantum well:

$$E(n, m) := \frac{n^2 \pi^2 \cdot \hbar^2}{2 \cdot m \cdot L^2}$$

$$E_{e1} := E(1, m_e) \quad \boxed{E_{e1} = 93.261 \text{ meV}} \quad \text{for electrons}$$

$$E_{p1} := E(1, m_p) \quad \boxed{E_{p1} = 11.051 \text{ meV}} \quad \text{for holes}$$

The total gap becomes:

$$E_{gtotal} := E_g + E_{e1} + E_{p1} \quad E_{gtotal} = 1.528 \text{eV}$$

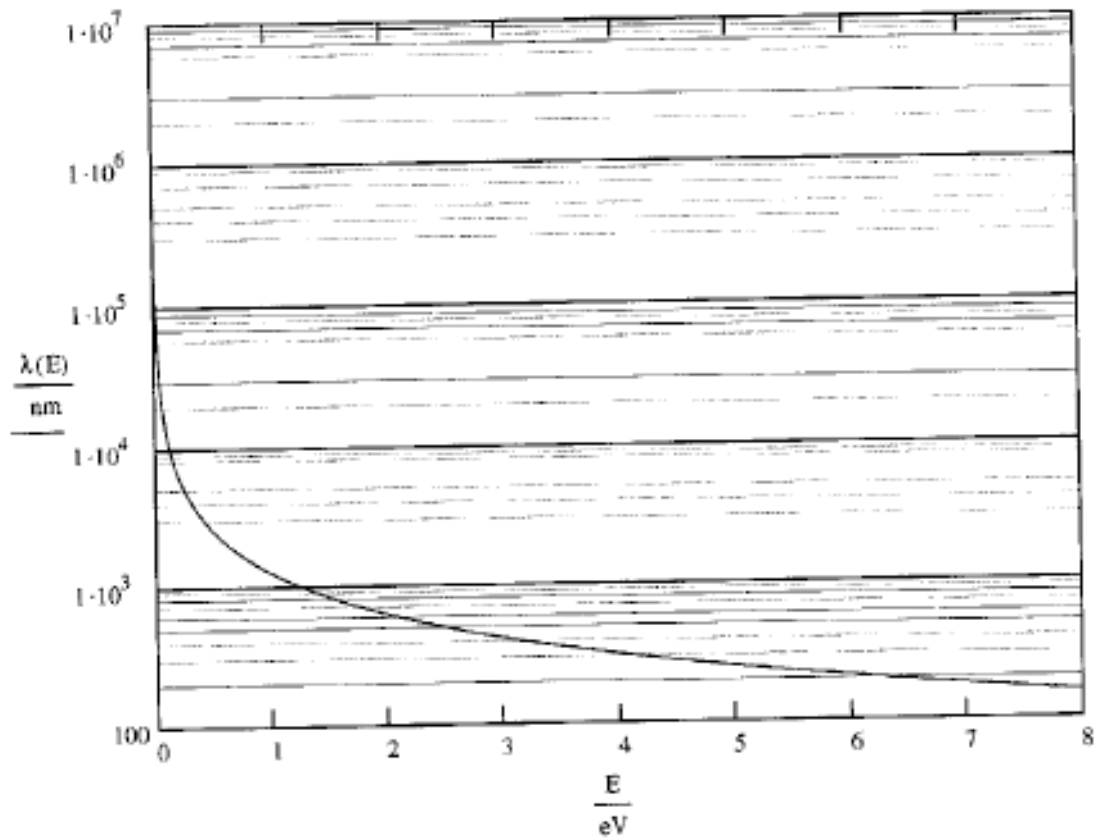
And finally we can find the wavelength of emitted light:

$$\lambda_{\text{emitted}} := \frac{h \cdot c}{E_{gtotal}} \quad \boxed{\lambda_{\text{emitted}} = 811.811 \text{ nm}}$$

This light would be in the infrared part of the spectrum.

$$\lambda(E) := \frac{h \cdot c}{E} \quad E := 0\text{eV}, .001\text{eV}.. 8.0\text{eV}$$

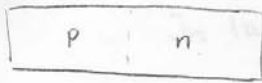
Just because I can here is a plot of wavelength in nm versus the Bandgap in eV.



PROBLEM 2: Next Page

Problem I: 5.11

From Fig. 1.15.



$$\begin{aligned} 1 \Omega\text{-cm} & \quad 0.2 \Omega\text{-cm} \\ \tau_n = 10^{-6} \text{ s} & \quad \tau_p = 10^{-8} \text{ s} \end{aligned}$$

$$P_p = 1 \Omega\text{-cm}, \quad P = 1.5 \times 10^{16} \text{ cm}^{-3}$$

$$P_n = 0.2 \Omega\text{-cm}, \quad n = 2.9 \times 10^{16} \text{ cm}^{-3}$$

ASSGNS

$$V_{bi} = \frac{kT}{q} \ln \frac{N_d \cdot N_A}{n_i^2}$$

suppose fully ionized, $N_d = n$, $N_A = P$

$$\begin{aligned} \therefore V_{bi} &= \frac{kT}{q} \ln \frac{nP}{n_i^2} = \frac{1.38 \times 10^{-23} \times 300}{1.6 \times 10^{-19}} \ln \frac{1.5 \times 10^{16} \times 2.9 \times 10^{16}}{(1.45 \times 10^{10})^2} \\ &= 0.722 \text{ (V)} \end{aligned}$$

(b) $n_{p0} = \frac{n_i^2}{P} = \frac{(1.45 \times 10^{10})^2}{1.5 \times 10^{16}} = 1.39 \times 10^4 \text{ cm}^{-3}$

$$P_{n0} = \frac{n_i^2}{n} = \frac{(1.45 \times 10^{10})^2}{2.9 \times 10^{16}} = 7.25 \times 10^3 \text{ cm}^{-3}$$

with applied bias:

$$n_p = n_{p0} \left(\exp \frac{qV}{kT} - 1 \right) = 1.35 \times 10^4 \text{ cm}^{-3}$$

$$P_n = P_{n0} \left(\exp \frac{qV}{kT} - 1 \right) = 7.06 \times 10^{13} \text{ cm}^{-3}$$

(c) $J_0 = q n_i^2 \left(\frac{D_p}{N_d L_p} + \frac{D_n}{N_a L_n} \right) = q n_i^2 \left(\frac{1}{N_d} \sqrt{\frac{D_p}{\tau_p}} + \frac{1}{N_a} \sqrt{\frac{D_n}{\tau_n}} \right)$

$$= 1.6 \times 10^{-19} \times (1.45 \times 10^{10})^2 \left(\frac{1}{2.9 \times 10^{16}} \sqrt{\frac{12.3}{10^{-8}}} + \frac{1}{1.5 \times 10^{16}} \sqrt{\frac{34.6}{10^{-6}}} \right)$$

$$= 5.387 \times 10^{-11} \text{ A/cm}^2$$

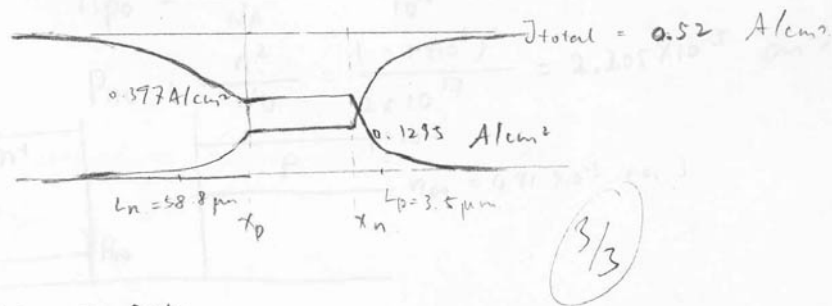
on p-side

$$J_n \text{ (at } x_p) = q D_n \frac{n_i^2}{N_A L_n} (e^{qV_0/kT} - 1)$$
$$= 1.6 \times 10^{-19} \times 34.6 \times \frac{(1.45 \times 10^{10})^2}{1.5 \times 10^{16} \times \sqrt{34.6 \times 10^{-6}}} (e^{23} - 1)$$
$$= 0.1285 \text{ A/cm}^2$$

on n-side

$$J_p \text{ (at } x_n) = q D_p \frac{n_i^2}{N_D L_p} (e^{qV_0/kT} - 1)$$
$$= 1.6 \times 10^{-19} \times 12.3 \times \frac{(1.45 \times 10^{10})^2}{2.9 \times 10^{16} \times \sqrt{12.3 \times 10^{-8}}} (e^{23} - 1)$$
$$= 0.397 \text{ A/cm}^2$$

$$J_{\text{total}} = J_0 (e^{qV_0/kT} - 1) = 5.387 \times 10^{-11} (e^{23} - 1)$$
$$= 0.52 \text{ A/cm}^2$$



(d) on n-side,

$$J_p = J_p \text{ (at } x_n) \cdot \exp\left(-\frac{x - x_n}{L_p}\right)$$

$$\text{when } J_p = J_n, \rightarrow J_p = \frac{1}{2} J_{\text{total}}$$

$$0.397 \times \exp\left(-\frac{x - x_n}{L_p}\right) = \frac{1}{2} \times 0.52$$

$$x - x_n = 1.48 \mu\text{m}$$

PROBLEM 3: NEXT PAGE

$$W = \sqrt{2 \frac{e \epsilon_s}{8} (V_{bi} - V_a) \left(\frac{1}{N_A} + \frac{1}{N_D} \right)}$$

$$= \sqrt{\frac{2 \times 11.7 \times 8.85 \times 10^{-14}}{1.6 \times 10^{-19}} \times 10.7382 - 0.587) \times 10^{16} \times \left(\frac{1}{1.5} + \frac{1}{3.0} \right)}$$

$$\approx 0.13 \mu\text{m} \quad N_A \cdot x_p = N_D \cdot x_n$$

$$\Rightarrow x_n = 0.045 \mu\text{m}, x_p = 0.09 \mu\text{m}$$

when $J_{maj} = J_{tot} - J_{min} \Rightarrow J_{min} = \frac{1}{2} J_{tot} = 0.247 \text{ A/cm}^2$

$$\therefore J_p(x) = 0.3790 \cdot e^{-\frac{x-x_n}{L_p}}$$

$$= 0.247$$

$\Rightarrow x = 1.4 \mu\text{m}$ from the x_n into the n-type region.

problem 2

a) $J_0 = q \left(\frac{D_n}{L_n} n_{p0} + \frac{D_p}{L_p} p_{n0} \right) = q n_i^2 \left(\frac{D_n}{L_n N_A} + \frac{D_p}{L_p N_D} \right)$ $D_n = 200 \text{ cm}^2/\text{s}$ $D_p = 10 \text{ cm}^2/\text{s}$

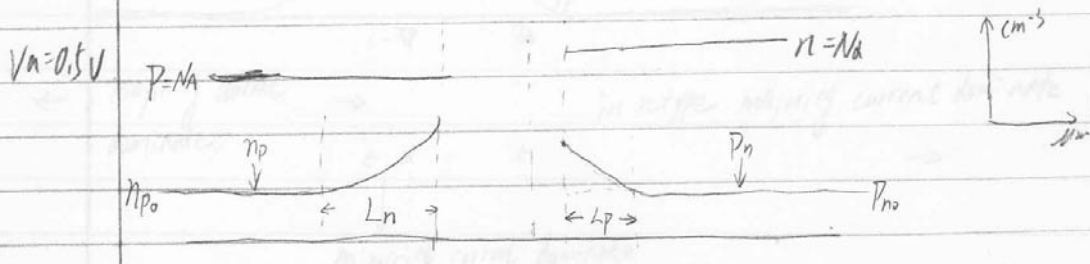
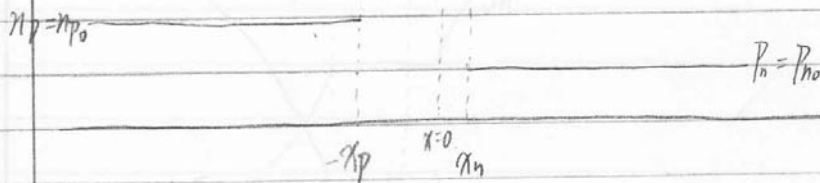
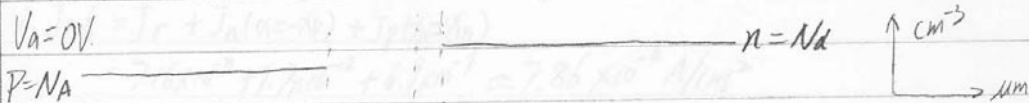
$$L_n = \sqrt{D_n \tau_n} = 0.0063 \text{ cm}$$

$$L_p = \sqrt{D_p \tau_p} = 0.0014 \text{ cm}$$

$$\therefore J_0 = 2.2365 \times 10^{-7} \text{ A/cm}^2$$

b) in the p-side $P = N_A \quad n_p = n_{p0} \cdot e^{\frac{qV_a}{RT}} \cdot e^{-\frac{x}{L_n}} = \frac{n_i^2}{N_A} \cdot e^{\frac{qV_a}{RT}} \cdot e^{-\frac{x}{L_n}}$

in the n-side $n = N_D \quad P_n = P_{n0} \cdot e^{\frac{qV_a}{RT}} \cdot e^{-\frac{x}{L_p}} = \frac{n_i^2}{N_D} \cdot e^{\frac{qV_a}{RT}} \cdot e^{-\frac{x}{L_p}}$



c). Outside depletion region in n-type

$$J_p = q n_i^2 \frac{D_p}{N_A L_p} (e^{\frac{qV_b}{kT}} - 1) e^{-\frac{x-x_n}{L_p}} \approx 7.7 \times 10^{-12} e^{-\frac{x-x_n}{L_p}} \quad x > x_n$$

Outside depletion region in p-type

$$J_n = q n_i^2 \frac{D_n}{N_A L_n} (e^{\frac{qV_b}{kT}} - 1) e^{\frac{x+x_p}{L_n}} = 6.9 \times 10^{-9} e^{\frac{x+x_p}{L_n}} \quad x < -x_p$$

$$\begin{cases} W = \sqrt{\frac{2 \epsilon_s}{q} (V_{bi} - V_a) \left(\frac{1}{N_A} + \frac{1}{N_D} \right)} \\ V_{bi} = \frac{kT}{q} \ln \frac{N_A N_D}{n_i^2} \end{cases}$$

$$\Rightarrow W = 0.81 \mu\text{m}$$

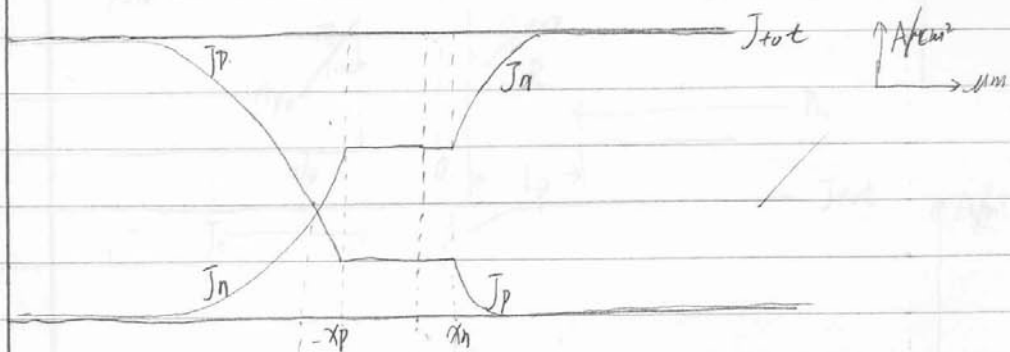
$$\text{At the junction } x=0, \quad E(0) = \frac{2(V_{bi} - V_a)}{W} = 16.75 \text{ kV/cm}$$

$$J_{\text{recombination}} = \frac{q n_i}{2\tau} \cdot \frac{kT}{qE(0)} \exp\left(\frac{qV_b}{2kT}\right) = 7.16 \times 10^{-8} \text{ A/cm}^2$$

In side the depletion region, the minority current is constant

$$\therefore J_{\text{tot}} = J_r + J_n(x = -x_p) + J_p(x = x_n)$$

$$= 7.16 \times 10^{-8} + 7.7 \times 10^{-12} + 6.9 \times 10^{-9} \approx 7.86 \times 10^{-8} \text{ A/cm}^2$$



← majority current dominate.

in n-type majority current dominate

minority current dominate

d). In the p-type region. $L_n = \sqrt{D_n \tau_n} = \sqrt{20 \times 0.2 \times 10^{-6}} = 0.0063 \text{ cm} \approx 63 \mu\text{m} \gg W_B$

$$\therefore \Delta n(x) = \frac{n_i^2}{N_A} \left(\frac{x+x_p}{W_B-x_p} + 1 \right) \left(e^{\frac{qV_A}{kT}} - 1 \right) \quad n(x) = \Delta n(x) + n_{p0}$$

$$\therefore J_n A x_p = N_D x_n$$

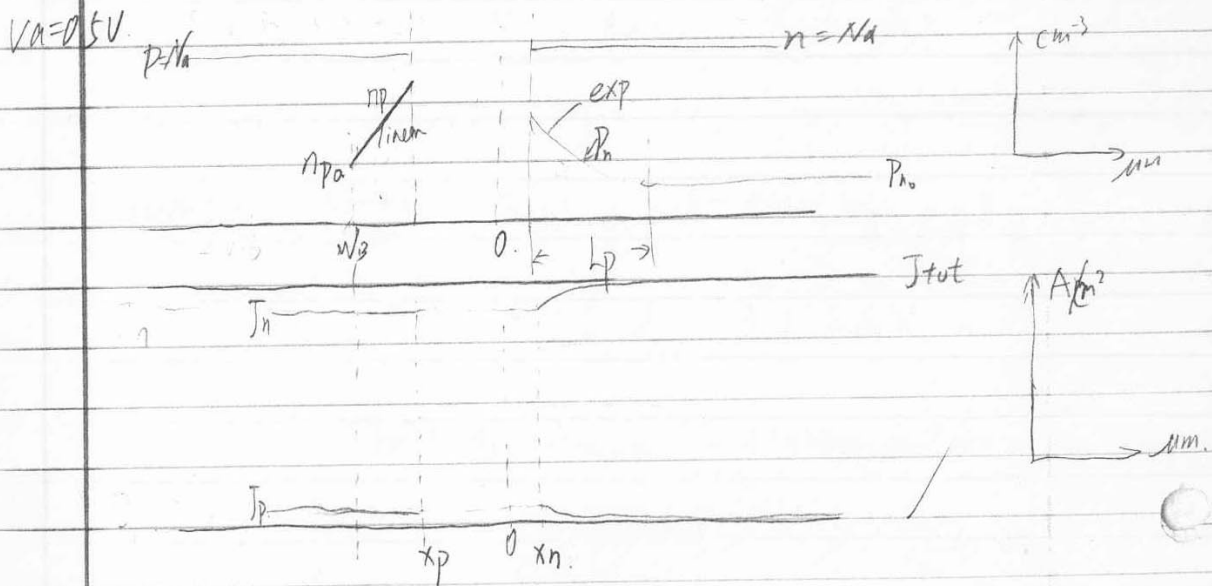
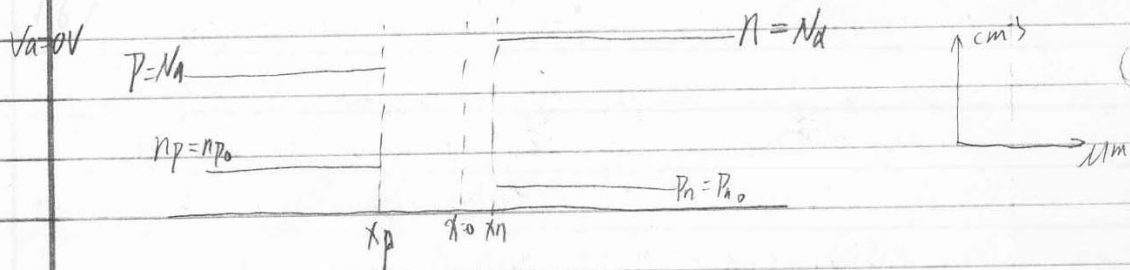
$$\therefore x_p \approx W = 0.8 \mu\text{m} ; \frac{qV_A}{kT} \gg 1 \Rightarrow J_p(x=x_n)$$

$$J_n = q D_n \frac{dn(x)}{dx} = \frac{q n_i^2 D_n}{N_A (W_B - x_p)} \left(e^{\frac{qV_A}{kT}} - 1 \right) \quad \text{where } x_p \approx W = 0.8 \mu\text{m}$$

$$\Rightarrow J_n(x=x_p) \approx 3.3 \times 10^7 \text{ A/cm}^2$$

J_{rec} is not changed. $J_{rec} = 7.16 \times 10^{-8} \text{ A/cm}^2$

$$J = J_n + J_p + J_{rec} \approx 4.0 \times 10^7 \text{ A/cm}^2$$



e. The current in long base diode is much smaller than the current in short base diode.

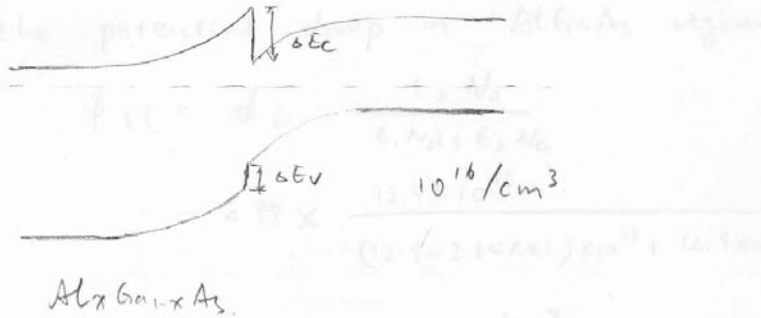
The reason is in long base diode $WB \approx L$, therefore most minority carrier has been combined before they reach the contact. While in short diode, $WB \ll L$. Therefore most minority carrier can get through the base without recombination. When they reach the contact, the current increase.

PROBLEM 4

For $\text{Al}_x\text{Ga}_{1-x}\text{As} / \text{GaAs}$ heterojunction:

when $x < 0.45$, electron affinity: $\chi = 4.07 - 1.1x$ eV

For GaAs , $\chi = 4.07$ eV



Since it is n^+p junction, electrons injected from n^+ to p region

$$J_n = - \frac{q D_n}{L_n} \frac{n_{i1}^2}{N_{A1}} \exp\left(\frac{\Delta E_g}{kT}\right) \left[\exp\left(\frac{qV_0}{kT}\right) - 1 \right]$$

to increase by 100, we can keep the doping same and introducing ΔE_g

$$\exp\left(\frac{\Delta E_g}{kT}\right) = 0.119$$

$$E_{g\text{AlGaAs}} - E_{g\text{GaAs}} = 1.155x + 0.37x^2 = 0.49 \text{ eV}$$

$$x = 0.1$$

$$\phi_i = \chi_2 - \chi_1 + \frac{E_{g2}}{q} - \frac{kT}{q} \ln \frac{N_{d1} N_{v2}}{N_{d1} N_{a2}}$$

$$= -1.1 \times 0.1 + 1.42 - \frac{kT}{q} \ln \frac{1.9 \times 10^{19} \times 9.5 \times 10^{18}}{10^{17} \times 10^{16}}$$

$$= -0.11 + 1.42 - 0.312$$

$$= 0.99 \text{ eV}$$

the potential drop in AlGaAs region:

$$\phi_{i1} = \phi_i \cdot \frac{\epsilon_2 N_a}{\epsilon_1 N_{d1} + \epsilon_2 N_a}$$

$$= 0.99 \times \frac{12.9 \times 10^{16}}{(12.9 - 2.84 \times 0.1) \times 10^{17} + 12.9 \times 10^{16}}$$

$$= 0.99 \times \frac{12.9}{12.6 \times 10 + 12.9}$$

$$= 0.09 \text{ eV}$$

$$\therefore \phi_{i2} = 0.9 \text{ eV}$$

In AlGaAs,

$$\frac{q N_d \chi_n^2}{2 \epsilon_1} = 0.09 \text{ eV}, \quad \chi_n = \sqrt{\frac{0.09 \times 2 \times 12.6 \times \epsilon_0}{1.6 \times 10^{-19} \times 10^{23}}}$$

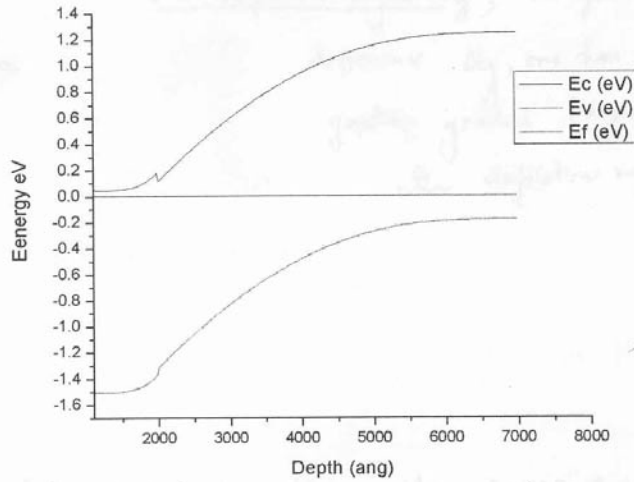
$$\chi_n = 3.54 \times 10^{-8} \text{ m} = 35.4 \text{ nm}$$

In GaAs

$$\frac{q N_d \chi_p^2}{2 \epsilon_2} = 0.9 \text{ eV}, \quad \chi_p = \sqrt{\frac{0.9 \times 2 \times 12.9 \times \epsilon_0}{1.6 \times 10^{-19} \times 10^{22}}}$$

$$\chi_p = 3.58 \times 10^{-7} \text{ m} = 358 \text{ nm}$$

With 1-V posin, for $\text{Al}_{0.1}\text{Ga}_{0.9}\text{As} / \text{GaAs}$ with doping of $1 \times 10^{17} / \text{cm}^3$ and $1 \times 10^{16} / \text{cm}^3$, we can see the ΔE_c is not very big.

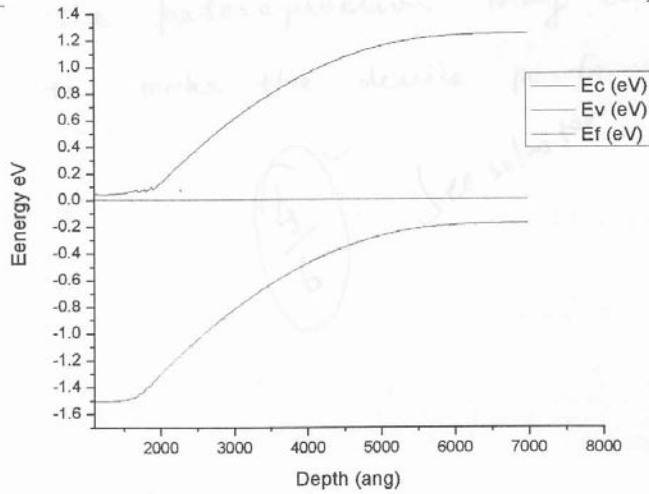


If I add 3 gradient layer to the structure, the ΔE_c kink could be removed:

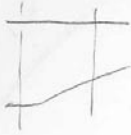
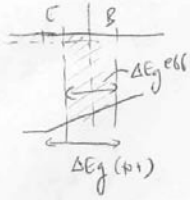
GaAs
 $\text{Al}_{0.01}\text{Ga}_{0.99}\text{As}$ 30 nm
 $\text{Al}_{0.04}\text{Ga}_{0.96}\text{As}$ 30 nm
 $\text{Al}_{0.07}\text{Ga}_{0.93}\text{As}$ 30 nm
 $\text{Al}_{0.1}\text{Ga}_{0.9}\text{As}$

$N_A = 1 \times 10^{16} / \text{cm}^3$
 $N_D = 1 \times 10^{17} / \text{cm}^3$

try 'graded' structure.



(c)



Since the $\frac{\Delta E_g}{e E_i}$ factor depends upon the ΔE_g across the E-B depletion region only, to get all the bandgap difference ΔE_g , one has to ensure that the ~~graded~~ graded layer lies entirely inside the depletion region.

(d) for heterojunction, the current is high

The disadvantage is: require epitaxial growth, thus increasing cost.

The heterojunction may contain defects to make the device performance worse.